

Notice of References Cited	Application/Control No. 10/730,063	Applicant(s)/Patent Under Reexamination SON, TAEHO	
	Examiner Eric S. McCall	Art Unit 2855	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-2004/0199131	10-2004	Kitamura, Teruo	604/318
	B	US-2004/0085200	05-2004	McConnel et al.	340/450.2
	C	US-2004/0079150	04-2004	Breed et al.	073/291
	D	US-2004/0005496	01-2004	Kelley et al.	429/91
	E	US-2001/0010171	08-2001	Atkinson, Harry	73/290.00V
	F	US-6,777,956	08-2004	Davis, Andrew Ceri	324/658
	G	US-6,598,473	07-2003	Atkinson, Harry	73/290V
	H	US-6,418,787	07-2002	Eck, Karl	73/290V
	I	US-5,747,689	05-1998	Hampo et al.	73/304C
	J	US-5,602,540	02-1997	Spillman, Jr., William B.	340/870.37
	K	US-5,602,333	02-1997	Larrabee et al.	73/149
	L	US-5,531,111	07-1996	Okamoto et al.	73/149
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
 Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.